

20V Dual N-Channel Enhancement Mode MOSFET

■ DESCRIPTION

The SMC9926 is the Dual N-Channel logic enhancement mode power field effect transistor is produced using high cell density advanced trench technology to provide excellent $R_{DS(ON)}$.low gate charge and operation gate as 1.8V.

This device is suitable for use as a load switch or other general applications.

SMC9926M-TRG ROHS Compliant This is Halogen Free

■ FEATURE

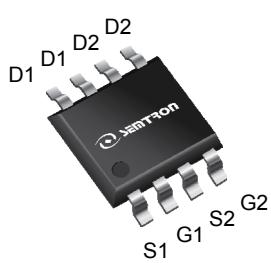
- ◆ 20V/8.0A, $R_{DS(ON)} = 17m\Omega$ (typ.)@ $V_{GS} = 10V$
- ◆ 20V/7.0A, $R_{DS(ON)} = 18m\Omega$ (typ.)@ $V_{GS} = 4.5V$
- ◆ 20V/6.0A, $R_{DS(ON)} = 23m\Omega$ (typ.)@ $V_{GS} = 2.5V$
- ◆ 20V/2.8A, $R_{DS(ON)} = 33m\Omega$ (typ.)@ $V_{GS} = 1.8V$
- ◆ Super high density cell design for extremely low $R_{DS(ON)}$
- ◆ Exceptional on-resistance and Maximum DC current capability

■ APPLICATIONS

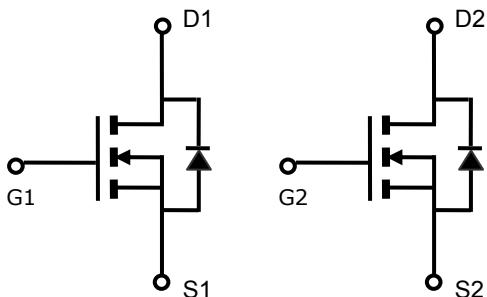
- ◆ Power Management
- ◆ Portable Equipment
- ◆ DSC
- ◆ LCD Display inverter
- ◆ Battery Powered System



■ PIN CONFIGURATION



SOP-8
Top View



SMC 9926 M - TR G a b c d e	a : Company name. b : Product Serial number. c : Package code d : Handling code e : Green produce code
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■ ORDERING INFORMATION

Part Number	Package Code	Handling Code	Shipping
SMC9926M-TRG	M : SOP-8	TR : Tape&Reel	2.5K/Reel

※ Year Code : 0 ~ 9, 2010 : 0

※ Week Code : A(1~2) ~ Z(53~54)

※ SOP-8 : Only available in tape and reel packaging.

■ ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter		Typical	Unit
V_{DSS}	Drain-Source Voltage		20	V
V_{GSS}	Gate-Source Voltage		± 12	V
I_D	Continuous Drain Current ($T_c=25^\circ C$) ^A	$V_{GS}=4.5V$	8	A
	Continuous Drain Current ($T_c=70^\circ C$) ^A		6.5	A
I_{DM}	Pulsed Drain Current ^B		30	A
P_D	Power Dissipation	$T_A=25^\circ C$ $T_A=70^\circ C$	2 1.4	W
T_J	Operation Junction Temperature		-55 to 150	$^\circ C$
T_{STG}	Storage Temperature Range		-55 to 150	$^\circ C$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient ^A Steady-State	-	85	$^\circ C/W$
$R_{\theta JL}$	Thermal Resistance Junction to Lead ^A Steady-State	-	50	$^\circ C/W$

ELECTRICAL CHARACTERISTICS($T_J = 25^\circ\text{C}$ Unless otherwise noted)

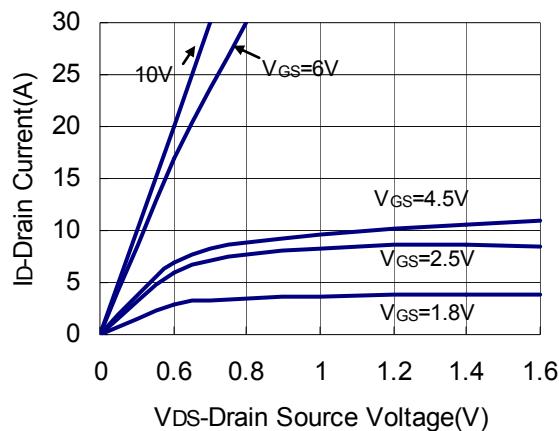
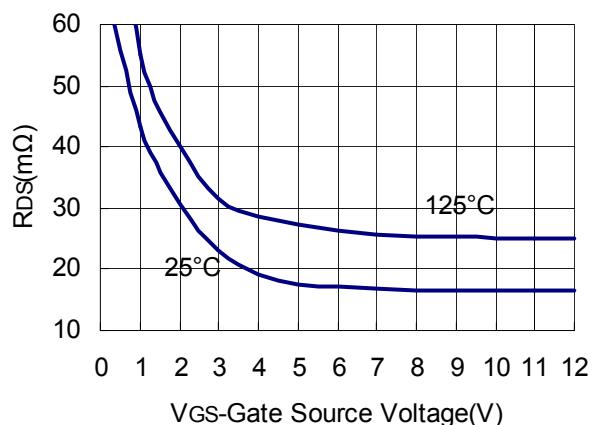
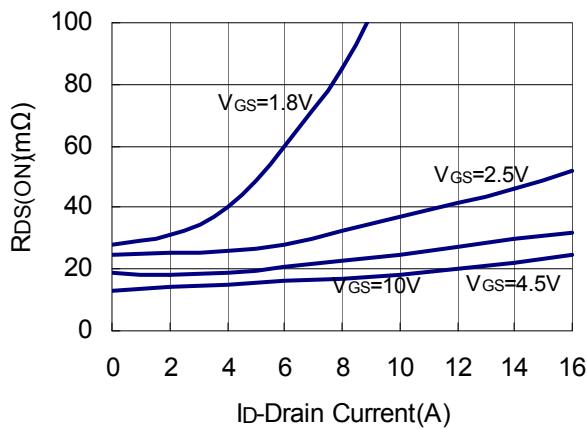
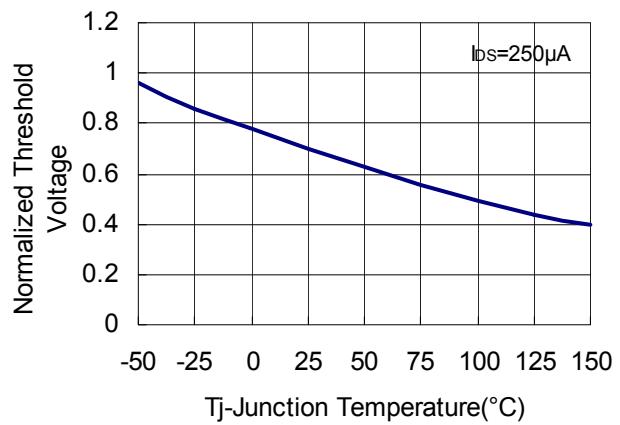
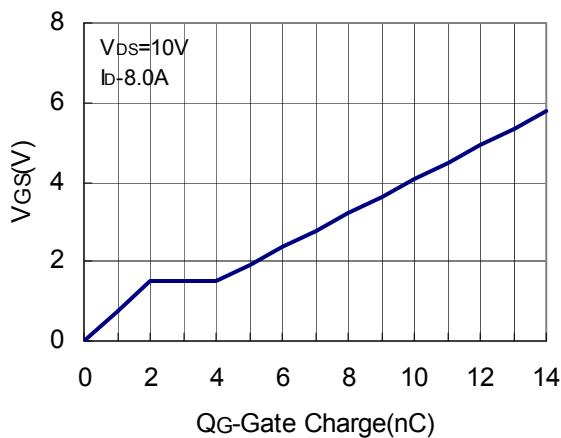
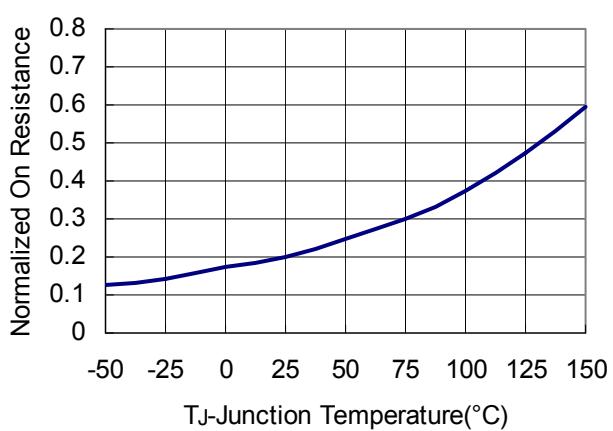
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	20			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.5	0.7	1.0	V	
I_{GSS}	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$			± 100	nA	
I_{DSS}	Zero Gate Voltage, Drain-Source Leakage Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$ $T_J=25^\circ\text{C}$			1	μA	
		$V_{DS}=20\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			5		
$R_{DS(\text{ON})}$	Drain-source On-Resistance ^B	$V_{GS}=10\text{V}, I_D=8.0\text{A}$		17	18	$\text{m}\Omega$	
		$V_{GS}=4.5\text{V}, I_D=7.0\text{A}$		18	20		
		$V_{GS}=2.5\text{V}, I_D=6.0\text{A}$		23	25		
		$V_{GS}=1.8\text{V}, I_D=2.8\text{A}$		33	40		
Source-Drain Diode							
V_{SD}	Diode Forward Voltage	$I_S=1.7\text{A}, V_{GS}=0\text{V}$		0.75	1.0	V	
I_S	Continuous Source Current ^{AD}				2.5	A	
Dynamic Parameters							
$Q_g(4.5\text{V})$	Total Gate Charge	$V_{DS}=10\text{V}$ $V_{GS}=4.5\text{V}$ $I_D=8.0\text{A}$		11.5		nC	
Q_{gs}	Gate-Source Charge			3.2			
Q_{gd}	Gate-Drain Charge			3.2			
C_{iss}	Input Capacitance	$V_{DS}=10\text{V}$ $V_{GS}=0\text{V}$ $f=1\text{MHz}$		605		pF	
C_{oss}	Output Capacitance			120			
C_{rss}	Reverse Transfer Capacitance			105			
$t_{d(on)}$	Turn-On Time	$V_{DD}=10\text{V}$ $I_D=1.0\text{A}$ $V_{GEN}=4.5\text{V}$ $R_G=6\Omega$		4.8		nS	
t_r				12.2			
$t_{d(off)}$	Turn-Off Time			32			
t_f				13			

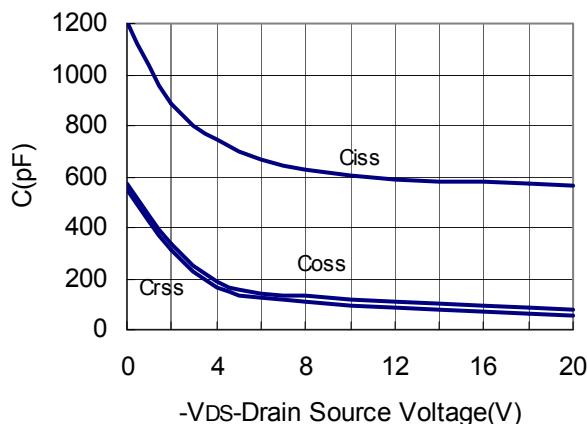
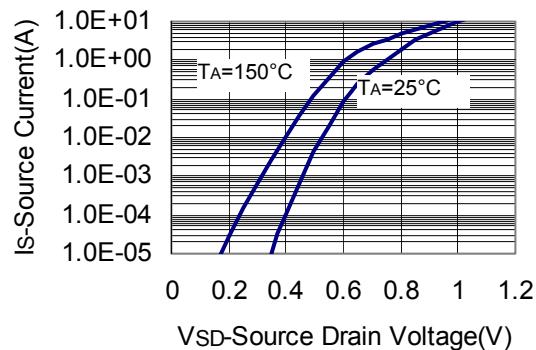
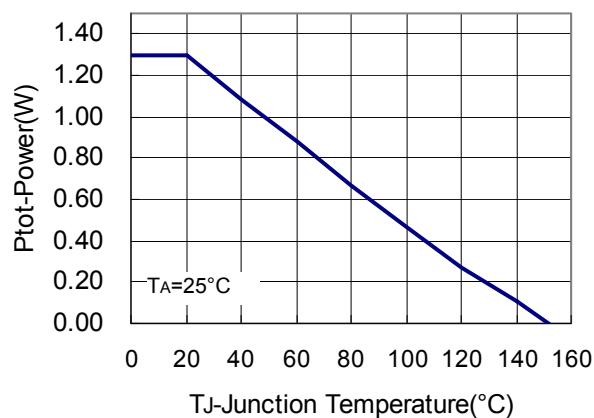
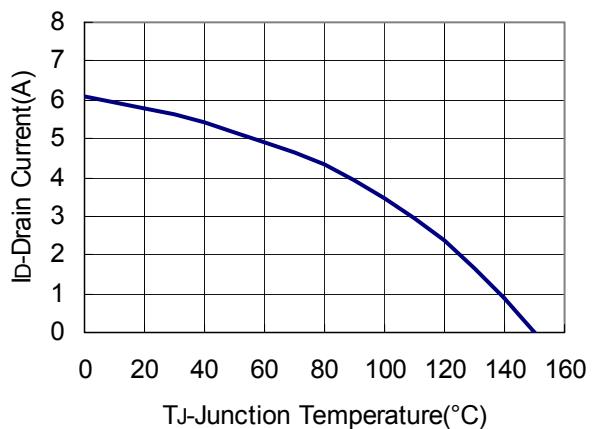
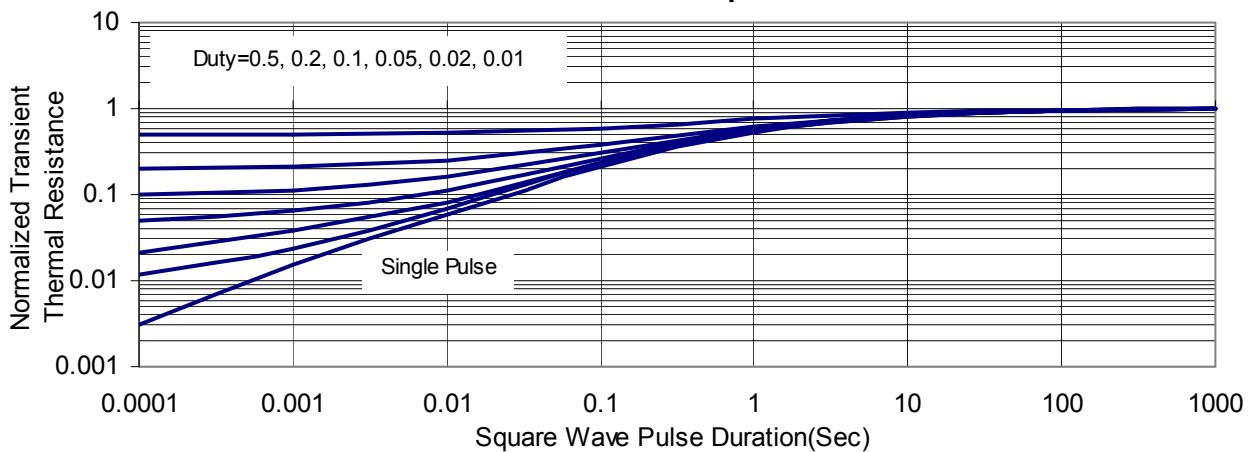
Note:

- A. The value of $R_{DS(on)}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.
- B. The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- C. The EAS data shows Max. rating. The test condition is $V_{DD}=20\text{V}, V_{GS}=12\text{V}, L=0.1\text{mH}$.
- D. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

The products and product specifications contained herein are subject to change without notice to improve performance characteristics. Consult us, or our representatives before use, to confirm that the information in this datasheet is up to date

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TYPICAL CHARACTERISTICS (25°C Unless Note)
Output Characteristics

Drain-Source On Resistance

Drain Source On Resistance

Gate Threshold Voltage

Gate Charge

Drain Source On Resistance


TYPICAL CHARACTERISTICS (25°C Unless Note)
Capacitance

Source Drain Diode Forward

Power Dissipation

Drain Current

Thermal Transient Impedance


SOP-8 PACKAGE DIMENSIONS

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.040	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 BSC		0.050 BSC	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

